Study of TES based microcalorimeters of different size and geometry under ac bias.

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Abstract—Frequency-division multiplexing (FDM) is the current baseline read-out system for the large array of superconducting transition-edge sensors (TES’s) under development for the X-ray instrument XIFU (Athena). In this multiplexing scheme the sensor operates as amplitude modulator of a MHz carrier. To achieve the best performance with these and similar instruments the detector physics and its interaction with the read-out circuit needs to be better understood. In particular we need an explanation for the dependence of the TES microcalorimeter non-linear impedance on the bias point, because it directly affects the choice of the detector optimal working point. With the TES microcalorimeters fabricated at NASA-Goddard we observe current steps in the amplitude of the uncalibrated I–V characteristics when the detectors are read-out in the frequency domain and are biased in the low resistance part of the superconducting transition. In this paper we report on the characterisation under FDM of NASA-Goddard TES microcalorimeters under development for the XIFU instrument. We have measured several pixels with different size and geometry in the bias frequency range from 1 to 4 MHz and at different bath temperatures. The results will be discussed within the recently developed weak-link theoretical framework.

I. INTRODUCTION

At SRON, we are developing the Frequency-division multiplexing (FDM) read-out system of a large array of superconducting transition-edge sensors (TES’s) for the XIFU [1] and the SAFARI [2] instruments on the future X-ray and infra-red space missions Athena and SPICA. A lot of progress has been made in the last years to understand the detector physics and a review has been recently published [3].

TES-based devices behave as weak-links due to longitudinally induced superconductivity from the niobium leads via the proximity effect [4], [5]. In our recent experimental works we have shown a clear evidence of the Josephson effects in ac biased TES bolometers and microcalorimeters [6], [7]. TES-based microcalorimeters are relatively more complex than bolometers. The microcalorimeters operate at larger bias current than bolometers, they are more sensitive to the self-generated magnetic field and the current flowing in the TES is not necessarily uniform due to the presence of normal metal structures employed to reduce the excess noise or to thermally couple the TES with the radiation absorber. TES current jumps, bistable effects and hysteretic behaviour have been recently reported in dc voltage biased TES microcalorimeters used in time-division multiplexers. With the TES microcalorimeters fabricated at NASA-Goddard we observe current steps in the uncalibrated amplitude of the I–V characteristic when the detectors are read-out in the frequency domain [6], [8], [9] and are biased in the low resistance part of the superconducting transition.

The effects observed under ac bias could find a natural explanation within the resistively shunted junction (RSJ) model. In this paper we have studied the TES I–V characteristic of several devices as a function of the bias frequency and bath temperature.

II. DETECTORS AND READ-OUT DESCRIPTION

The devices under test are NASA-Goddard X-ray Mo/Au bilayer TES microcalorimeters from a uniform 8×8 array [10] and from a mixed array with different detector designs and configurations. In the uniform array the TES’s are 150µm×150µm large and are coupled to a micron-thick overhanging 242µm×242µm Au/Bi X-ray absorber. The pixels have an intrinsic transition temperature of TC ≈ 95 mK, and a normal state resistance of RN ≈ 8 mΩ. In the mixed array we have tested four different pixel designs: a 50µm×50µm Mo/Au
TES on Si substrate with a central Au dot coupling to a 242 \( \mu \text{m} \times 242 \mu \text{m} \) Au/Bi absorber, and three pixel types with TES size respectively of 100 \( \mu \text{m} \times 100 \mu \text{m} \), 120 \( \mu \text{m} \times 120 \mu \text{m} \) and 140 \( \mu \text{m} \times 140 \mu \text{m} \), deposited on a SiN membrane and with a geometry similar to the uniform array pixels. The pixels in the mixed array have normal resistances of about 10 m\( \Omega \), a \( T_C \) between 95 and 100 mK, and a nominal thermal conductance \( G \) to the bath respectively of 700 pW/K, 207 pW/K, 250 pW/K and 310 pW/K. The pixels layout is shown in Fig. (1).

For the ac measurements we use a FDM system similar to the one described in [8] and working in the frequency range from 1 to 4 MHz. The readout, shown in Fig. (1), is based on a low noise two-stage SQUID amplifier fabricated at VTT [11], [12] and high-\( Q \) \( LC \) filters developed at SRON using superconducting Nb film and amorphous Si lithographic technology [13]. The \( LC \) filters used in this work have an inductance of \( L = 2 \mu \text{H} \) and \( L = 400 \text{nH} \) for the uniform and the mixed array respectively. Superconducting flux transformers with 8-to-1 and 5-to-1 ratio are used to optimize the impedance matching between the SQUID amplifier and the TES’s. The SQUIDs, the \( LC \)-filters and the TES array chips are mounted on a copper bracket assembled on a removable probe of a cryogen-free dilution refrigerator from Leiden Cryogenics [14].

### III. Experimental results

We measured the critical current \( I_c \) as a function of the bath temperature \( T_{\text{bath}} \) for several devices of the mixed array biased at different frequencies. A collection of all the \( I_c \) curves is presented in Fig. (2) as a function of \( T_{\text{bath}} \) normalized to the critical temperature \( T_c \) of the TES.

The critical current of similar devices measured under dc bias [15], [16] is also added to the data set. For the sake of clarity, when comparing critical currents, the peak current value of the ac current is used, since the transition to the normal state first occurs at the maximum current flowing into the TES. In the I-V characteristic under ac bias, the current and voltage are given in rms values. Close to \( T_c \) the critical current shows the typical exponential decay of a weakly linked superconductor and the values measured under ac and dc bias are consistent with each other. At low \( T_{\text{bath}} \) the critical currents measured under ac bias saturate at lower values, which depend on the bias frequency.

This is very likely caused by additional dissipation internally to the TES, which is sufficiently high to keep the device hotter than \( T_{\text{bath}} \). As a matter of fact the contribution from the losses in the \( LC \) bias circuit and the superconducting transformers were measured, during a calibration run without the TES’s, to be smaller than \( 5 \times 10^{-5} \Omega \).

An estimation of the magnitude of the ac losses is shown in Fig. (2)b, where \( r = P/I_c^2 \) is plotted as a function of \( T_{\text{bath}} \). \( P \) is the pixel power obtained from the calibration of the TES \( I-V \) curves. The resistances derived from the \( I_c(T_{\text{bath}}) \) curve tend to a constant value at low temperature ranging from 1 m\( \Omega \) to 2.5 m\( \Omega \) depending on the bias frequency. The measured ac losses are a significant fraction of the TES resistances in particular at high bias frequencies. The losses are likely due to the presence of the normal metal structure on the TES calorimeters introduced to mitigate the detector noise. The losses measured in the superconducting state of the 50 \( \mu \text{m} \) TES pixel, which has only a small normal dot in the center of the TES for the thermal coupling to the absorber, are smaller than the pixels with normal bars, even at a high bias frequency. We need to further investigate whether the losses are generated for example by eddy currents or by more sophisticated proximity effects in the normal structures of the TES.

In Fig. (3) the TES in-phase current \( I_I \) and the quadrature current \( I_Q \) are shown as a function of the TES voltage for 5 pixels biased respectively at 1.3, 1.4, 1.8, 2.0 and 2.4 MHz, at zero magnetic field (\( B < 0.6 \mu \text{T} \)) and \( T_{\text{bath}} = 55 \mu \text{K} \). The TES current is calibrated by using the SQUID read-out circuit parameters and the voltage by using the power estimated in the normal branch of the \( I-V \) curve given the TES normal resistance \( R_N \). We assume the TES to be fully resistive at large bias voltage and we use the phase measured in the normal state to calibrate out any phase shift caused by the read-out circuit. A continuum phase shift during the TES transition, not fully understood and currently attributed to a non-ideal behaviour of the superconducting transformer, has been removed from the phase before calculating \( I_I \) and \( I_Q \). A more detailed description of the calibration of TES \( I-V \) characteristics under ac bias will be published in the near future.

For high TES voltage (i.e high TES resistance) \( I_I \) shows the typical \( I-V \) characteristics of a voltage biased TES. At low bias voltage (\( V < 0.1 \mu \text{V} \)) (where the TES is supposed to become superconducting, but still shows a residual resistance) steps appear in the current with a complex, though reproducible, structure. This effect could be related to the excess losses inferred from the \( I_c(T) \) curves presented above. More measurements with a larger variety of pixels are needed to gain more insight into this topic.

The quadrature current shows the oscillatory dependence on the bias voltage typical of the Josephson current and observed in the ac biased bolometers [7] as well. The Josephson current flowing in the TES is in general about 10 \( \div 20\% \) of the normal current. Being it \( \pi/2 \) out-of-phase with respect to the TES voltage, it is related to the reactive component of the TES impedance and it affects the dynamics of the detector. The more complicated structure observed at low bias voltage is related to the nature of the transition and the non-linear impedance of the TES. The effect is not fully understood yet and is still under investigation. It is worth noting that the exact shape of \( I_I \) and \( I_Q \) strongly depends on the shape of the TES transition, which is not necessarily identical for the pixels of the array under test.

We measured the \( I-V \) curves as a function of bath temperature to understand how the oscillatory behaviour in the quadrature current depends on the total current flowing in the TES. The higher the bath temperature the smaller the current in the TES. The results are plotted in Fig. (4) for the pixel biased at 1.3 MHz. The threshold at which the
Fig. 2. a) $I_C(T)$ curves for several TES as a function of the normalized bath temperature $T_{bath}$. The black points are the critical current of similar devices under dc bias [15], [16]. b) Estimated losses $r = P/I^2$ from the critical current. (Colour figure online.)

Fig. 3. I-V characteristics of the TES’s as a function of bias frequency at $T_{bath} = 55 \text{ mK}$. Current in-phase (upper plot) and in quadrature (lower plot) with the voltage. The quadrature current for each pixel has been shifted vertically by $+7 \mu\text{A}$ for clarity. (Color figure online.)

Fig. 4. I-V characteristics of a TES as a function of the $T_{bath}$ for the pixel biased at 1.3 MHz. Current in-phase (upper plot) and in quadrature (lower plot) with the voltage. The quadrature current for each pixel has been shifted vertically by $+7 \mu\text{A}$ for clarity. (Color figure online.)

oscillations become visible in $I_I$ moves to lower voltages at higher bath temperature, following the amplitude of $I_I$. This hints to the fact that the effect is mainly related to the detector impedance. The pixels from the mixed array show a behaviour similar to the 140 $\mu\text{m}$ pixels from the uniform array reported above. From the $I_I$, $I_Q$ and the calibrated TES voltage we can calculate the TES resistance and the reactance respectively.

Preliminary results are plotted in Fig. (5) for the 100, 120 and 140 $\mu\text{m}$ devices of the mixed array, biased respectively at frequencies of 3.3, 1.7 and 2.7 MHz. The analysis of the $I-V$ curves of the 50 $\mu\text{m}$ pixel has not been finalized yet and the results will be reported elsewhere. Here below we present a qualitative interpretation of the measurements for the larger pixels with normal metal bars.

The three devices show similar behaviour. It is important to note that the periodicity of the oscillation depends on the bias frequency as it follows from the standard weak-link theory and experimentally confirmed with TES bolometers [7]. Measurements done with similar pixels at different bias frequencies, not presented in this paper, do not show substantial difference from the data plotted here, except for the periodicity of the oscillations. The TES reactance is zero at large voltage when the pixel is in the normal state and it has an oscillatory dependence on the bias voltage at the superconducting transition. The reactance shows smooth oscillations at high resistance, which become sawtooth-like at low voltage bias.

We have calculated the TES non-linear impedance by solv-
We have studied the ac response of several TES microcalorimeters with different size and geometry. We discovered an additional internal dissipation mechanism in the ac biased TES calorimeter. The excess losses depend on the bias frequency and are particularly enhanced in TES with biased TES calorimeter. The excess losses are plotted with red dashed curves in Fig. (5). This simple model fairly reproduces the major feature observed in the TES reactance. As explained in McDonald and Clem [17] the sharp changes in the reactance occur at values of the TES current for which there are bifurcations in the solutions of the non-linear equation. More details on the dependency of the solutions on the TES parameters will be presented in a future publication. To explain the fine structure observed in the experimental data a more sophisticated model is required. In particular we need to solve the resistive network to include the effect of the normal structure in the electrical resistance and make a realistic estimation of the current distribution in the device [18].

IV. CONCLUSION

We have studied the ac response of several TES microcalorimeters with different size and geometry. We discovered an additional internal dissipation mechanism in the ac biased TES calorimeter. The excess losses depend on the bias frequency and are particularly enhanced in TES with normal metal bars introduced to mitigate the detector noise under dc bias. For the large TES’s with normal bars we have measured and analysed the \( I - V \) characteristics. For all the devices, the quadrature TES current measured as a function of the TES voltage shows an oscillatory dependence, which is related to the nature of the resistive transition and to the behaviour of the TES as a weakly-linked superconductor. We have studied experimentally the dependency of the observed structures in the TES current as a function of the pixel geometry, the bias frequency and the bath temperature. The main features observed in the non-linear impedance of the TES microcalorimeters can be, at least qualitatively, explained using the RSJ model applied to a small uniform weak-link. A more sophisticated model that will include the effect of a non uniform current distribution in the TES is under development. From the preliminary results presented here, there is no evidence of a strong dependence of the detector response on the TES size. More tests have been planned for the future using a mixed array from NASA-Goddard with TES’s with a larger variety of geometries.

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